

<b>Notice of References Cited</b>	Application/Control No. 10/668,421	Applicant(s)/Patent Under Reexamination BERMEL ET AL.	
	Examiner Erin D. Chiem	Art Unit 2883	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,808,781	09-1998	Arney et al.	359/291
	B	US-6,808,654	10-2004	Hayashi et al.	252/512
	C	US-5,238,636	08-1993	Furukawa et al.	264/41
	D	US-5,141,461	08-1992	Nishimura et al.	445/52
	E	US-4,133,798	01-1979	Nishimura et al.	524/485
	F	US-2002/0154261	10-2002	Kralik, John C.	349/117
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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